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Resolving Triblock Terpolymer Morphologies by Vapor-Phase Infiltration

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ABSTRACT: The spontaneous formation of well-organized three-dimensional (3D) nanostructures from self-assembled block copolymers (BCPs) holds promise for nanofabrication and lithography. The addition of a third block to BCPs provides access to a plethora of 3D geometries, but it remains difficult to resolve the geometry of such “three-color” structures when there is low contrast between the polymeric components at length scales of a few nm. Here, we apply vapor-phase infiltration synthesis to a silicon-containing triblock terpolymer, poly(1,1-dimethyl silacyclobutane-*b*-styrene-*b*-lactide) (PDMSB-*b*-PS-*b*-PLA or DSL) to distinguish the 3D microdomain morphologies of the two organic blocks, PLA and PS. Selective infiltration of ZnO within the PLA microdomains reveals morphologies consisting of three-color lamellae or lamellae combined with vertically aligned core-shell cylinders, depending on the volume fractions of each block. The infiltration produces ZnO nanoparticles throughout the 260 nm thickness of the DSL film, generating 3D nanocomposites containing ZnO and SiO_x. These results provide a strategy for synthesizing multicomponent 3D nanostructures as well as visualizing the phase behavior of multi-block copolymers.

KEYWORDS: three-dimensional self-assembly, triblock terpolymer, infiltration synthesis, metal oxide, three-color nanostructure.

INTRODUCTION

Three-dimensional (3D) nanofabrication is essential for producing a host of useful materials and structures for applications such as electronic devices, nanoporous membranes and functionalized surfaces.¹⁻⁶ Self-assembly of block copolymer (BCP) thin films in particular offers an efficient route to produce a variety of 3D nanostructures, taking advantage of its simple sequence of processing steps.⁷⁻¹⁴ Compared with diblock copolymers, triblock and multiblock polymers can produce nanostructures with greater structural diversity and additional chemical functionalities,¹⁵⁻²⁰ and there has been an increasing emphasis on understanding their self-assembly and 3D morphologies.²¹⁻²⁵

However, it is challenging to resolve the morphologies of 3D BCPs comprising more than two polymeric components unless there is good contrast between the microdomains, for example a contrast in density, chemical composition, or reactivity. Block-selective etching followed by plan-view or cross-sectional imaging using scanning electron microscopy (SEM) is commonly used to characterize BCP morphologies, but the organic blocks are often difficult to distinguish.^{23,26} X-ray scattering is used for 3D structural analysis, but it requires a scattering contrast between the blocks, for example the presence of metal or Si in one block,^{13, 23} and analysis of triblock morphologies (beyond measuring the periodicity) requires modeling the structure factor.

Vapor-phase infiltration (VPI) refers to variations of *ex situ* material hybridization techniques based on atomic layer deposition (ALD) including multi-pulse infiltration,²⁷ sequential vapor infiltration (SVI),²⁸ and sequential infiltration synthesis (SIS),²⁹ where vapor-phase inorganic precursors perfuse the polymer matrix to generate unique organic-inorganic hybrids with improved material properties. When applied to a self-assembled BCP, it can greatly enhance the scattering contrast and the etch resistance between blocks by selectively incorporating inorganic material

such as ZnO, TiO₂, or Al₂O₃ into specific microdomains.²⁷⁻³⁷ The infiltration process proceeds *via* sorption (diffusion) and block-selective reaction of vapor-phase organometallic precursors into the polymer blocks with suitable reactive moieties to generate infused inorganic materials within the target BCP microdomains.³⁸⁻³⁹ The hybrid nanocomposite thus formed can also be converted to an inorganic nanostructure inheriting the original structure of the polymer microdomains,^{34,36} not only producing various functional nanostructures in a simple process but also enabling all-organic BCP morphologies to be fully resolved.³¹ ALD of metal oxide precursors into cylinder- and gyroid-forming BCPs has been used to generate 1D and 3D nanostructures for a broad variety of nanotechnologies such as gas sensors, solar cells, photocatalysts, and pattern transfer masks.^{14, 32, 35, 40-42}

While the majority of the reports exploiting infiltration synthesis of BCPs are focused on diblock copolymers, the process is also applicable to BCPs containing three or more blocks such as triblock terpolymers (TBTPs).³⁷ In this work we demonstrate the infiltration of inorganic species into poly(1,1-dimethyl silacyclobutane-*block*-styrene-*block*-lactide) (PDMSB-*b*-PS-*b*-PLA or DSL), a silicon-containing TBTP with two organic blocks, PS and PLA. Our previous study of one composition of DSL reported the formation of microdomains consisting of core-shell cylinders perpendicular to perforated lamellae, based on SEM and grazing-incidence small-angle X-ray scattering (GISAXS) characterization.²³ The PDMSB was clearly resolved but it was difficult to differentiate between the PLA and the PS blocks. In this work, we demonstrate the effects of ZnO infiltration into a series of DSL compositions that includes both lamellar and lamellar plus hexagonal cylinder morphologies. We first investigate the phase behavior of four DSLs with different *volume fractions* of each block and then show that infiltration synthesis introduces ZnO

into the PLA microdomains. These results not only reveal the microdomain morphologies of the DSL, but demonstrate the formation of nanocomposites with ZnO, silica and organic components.

RESULTS AND DISCUSSION

Figure 1. (a) Chemical structure of DSL and schematic illustrations of self-assembled DSL films. The dominant morphologies obtained in this study for each DSL are presented. DSL-L with symmetric PDMSB and PS compositions form alternating in-plane lamellae (left) and DSL-H with asymmetric PDMSB and PS fractions exhibit in-plane lamellae combined with hexagonally packed vertical core-shell cylinders (right). Schematics in light grey, blue, and red represent PDMSB, PS, and PLA, respectively. (b) SEM images of the final morphologies in DSL films: Top view (left), plan view of terraced layers (middle), and side view (right). The images mainly show contrast from the oxidized PDMSB nanopatterns.

DSL (**Figure 1a**) was synthesized using anionic polymerization combined with ring opening polymerization as described in the Methods section and Ref (23). We previously described the syntheses of PDMSB-*b*-PS-*b*-poly(methyl methacrylate) (DSM)^{23,37,43} and PDMSB-*b*-PS-*b*-poly(2-vinylpyridine) (DSV).²⁵ The PDMSB (not to be confused with PDMS, polydimethylsiloxane) monomeric unit is composed of butane with one Si atom in the backbone. DSL films of 180–260 nm thicknesses were spin cast onto Si substrates and annealed in a solvent vapor flow of CHCl₃. The organic blocks were etched by oxygen plasma reactive ion etching (RIE) and both top and side views of the structure were characterized by SEM. Further analysis was carried out using transmission and scanning transmission electron microscopy (TEM/STEM) and elemental mapping using energy dispersive spectroscopy (EDS). The bulk morphology of vacuum annealed samples was characterized using small angle x-ray scattering (SAXS).

Table 1. DSL properties, morphologies, and periods in thin films.

	Molecular weight, M_n [kg/mol]	Dispersity, M_w/M_n	Composition, $f_{\text{PDMSB}}/f_{\text{PS}}/f_{\text{PLA}}$	Thin film thickness [nm]	Thin film morphology	Period [nm] ^{a)}
DSL-L1	28.4	1.15	0.41/0.40/0.19	180	Lam//	21
DSL-L2	25.8	1.12	0.36/0.36/0.28	210	Lam//	16
DSL-H1	55.5	1.09	0.25/0.40/0.35	240	Lam//–Hex _⊥	21, 38
DSL-H2	38.4	1.07	0.31/0.53/0.16	260	Lam//–Hex _⊥	17, 35

Lam, alternating lamellae; Hex, hexagonally packed core-shell cylinders; //, lateral alignment; ⊥, vertical alignment; ^{a)}Estimated from SEM and TEM images; the two values for DSL-H1 and H2 correspond to the out-of-plane lamellar spacing and the in-plane pore spacing respectively.

Four DSL compositions were used in this study (**Table 1**). DSL-L1 and DSL-L2 had symmetric PDMSB and PS volume fractions, while DSL-H1 and DSL-H2 had a volume fraction of PS that was ~ 1.5 times that of PDMSB. DSL-H2 is the same polymer composition reported in Ref (23). The SAXS data for the bulk DSLs are shown in **Figure S1**. The SAXS contrast originates from the difference in scattering between the PDMSB and the organic blocks. DSL-L1 showed lamellar (Lam) and DSL-L2 showed hexagonally packed cylindrical (Hex) morphologies with period $L_0 = 23.2$ nm and **31.4** nm respectively. DSL-H1 exhibited broad peaks, due to its larger molecular weight, and has been tentatively indexed to hexagonally-perforated lamellae (HPL) with an AB stacking ($L_{100} = 39.2$ nm), *i.e.* HPL with the perforations in one layer located above the junctions in the adjacent layers, while DSL-H2 showed peaks from a mixture of Hex ($L_0 = \text{19.0}$ nm) and Lam ($L_0 = 36.9$ nm) structures.

SEM images of DSL films after oxygen RIE are shown in **Figure 1b**. In both DSL-L1 and L2, the plan view images show no periodic features but in-plane lamellae (Lam_{//}) are observed in the cross-sectional images. This technique does not reveal any contrast between PS and PLA microdomains, showing only the PDMSB lamellae alternating with the non-Si-containing blocks. The Lam structure agrees with the bulk morphology of the DSL-L1, but the DSL-L2 was Hex in bulk, and the Lam thin film structure may be a result of the preferential swelling of PDMSB domains by CHCl₃ during the solvent annealing leading to an effective increase in volume fraction. Note that differences between the bulk and thin film morphologies have also been observed for both DSV²⁵ and DSM⁴³ samples.

For the DSL-H1 and H2 films, the top view SEM images (**Figure 1b and S2**) clearly exhibit a hexagonal pore array attributed to out-of-plane cylindrical morphology, Hex_⊥. The pores show a core-shell morphology assumed to consist of a PS shell and a PLA core, evident from a difference

in their etching rate in the O₂ plasma. To examine the structure at different depths, we introduced an angled plasma RIE followed by SEM imaging from the top surface (see Methods). This reveals terraces showing vertical alignment of the core-shell cylinders throughout the film, in agreement with the DSL-H2 results in Ref (23). Cross-section imaging of both DSL-H1 and H2 show in-plane Lam_{//} with vertical features corresponding to the cylinders passing through the perforations in the lamellae. We therefore describe the structure as Lam_{//}-Hex_⊥. Our earlier work²³ on DSL-H2 also showed about 20 % of the film had a morphology attributed to alternating in-plane cylindrical microdomains (Alt_{//}); a similar result was found in the present work for DSL-H2 but no in-plane cylinders were found in DSL-H1.

To clarify the distribution of PS and PLA within the microphase-separated DSL films, we employed infiltration synthesis to infuse ZnO selectively within the PLA microdomains. ZnO infiltration consisted of cyclic exposures of the BCP film to diethylzinc (DEZ) and water, which are precursors respectively for Zn and O. In total 6 cycles were performed, assisted by an initial single AlO_x infiltration cycle using trimethylaluminum (TMA) and water (referred to as AlO_x priming).^{30, 44-45} During an infiltration synthesis cycle, gaseous organometallic precursors, which are typically Lewis acids, diffuse into the polymer matrix and react with Lewis-basic functional groups within the polymer to form chemical bonds. A subsequent exposure of the film to an oxidizing agent, such as water, transforms the pre-infiltrated organometallic precursor into metal oxide molecules. In the DSL films, only the PLA block contains a Lewis-basic carbonyl group and, thus, metal oxide moieties are expected to be selectively infiltrated into the PLA domain. However, similar to the well-studied PMMA, the carbonyl group within PLA does not readily react with weakly Lewis-acidic DEZ.^{30, 34, 44-45} This was mitigated by the AlO_x priming, because the more Lewis-acidic TMA can react better with the carbonyl group and generate -Al-OH species in the

PLA domain once the priming cycle is completed with water. The available OH group then can readily react with DEZ, facilitating the subsequent infiltration cycles of ZnO.

Figure 2. (a) Schematic illustrations depicting the solvent vapor annealing (SVA) followed by **infiltration** synthesis to produce SiO_x/PS/ZnO nanostructures in DSL-L films. The purple structure in the spin-coated DSL film represents as-cast DSL-L before microphase separation. Schematics in **light grey**, blue, red, grey, and yellow represent PDMSB, PS, PLA, SiO_x, and ZnO, respectively. (b) Schematic illustrations (left) of the cross-sections of DSL-L structure before (top) and after (bottom) **infiltration** of ZnO and TEM images (right) of resultant SiO_x/PS/ZnO nanostructure in DSL-L1 film. (c) HAADF STEM images and associated EDS elemental mappings (Si and Zn) for cross-sections of ZnO-infiltrated DSL-L1.

Figure 2a shows schematics of the proposed structure of the DSL-L thin films after infiltration, with ZnO present in the PLA blocks. **Figure 2b** shows a cross-sectional bright-field TEM image of DSL-L1 after ZnO infiltration. The dark and uniform in-plane lamellae consist of the Si-containing PDMSB block. However, additional layers are evident within the in-plane lamellae which are identified as ZnO-infused PLA, confirming the alternating 3-color lamellar structure of DSL-L1. DSL-L2 shows similar morphology, shown in **Figure S3 and S4**. The ZnO-infiltrated PLA lamellae exhibit rough interfaces and a sparse distribution of ZnO particles, which is attributed to the small volume fraction of PLA ($f_{\text{PLA}} = 0.19$) in DSL-L1. The discontinuous ZnO growth inside the PLA domain could also result from the single AlO_x-priming cycle that is insufficient to provide uniform reactivity with the infiltrating DEZ; we did not pursue AlO_x-only infiltration due to the lack of Z-contrast between Al and Si, but this was demonstrated previously for DSM where the PMMA cores of core-shell cylinders were decorated with alumina.³⁷ DSL-L2 which includes a larger fraction of PLA ($f_{\text{PLA}} = 0.28$) exhibits more homogeneous ZnO layers in between PS lamellae (**Figure S3 and S4**).

The ZnO-infiltrated DSL-L1 structure was analyzed by high-angle annular dark-field (HAADF) imaging and EDS elemental mapping (**Figure 2c**). HAADF images sensitive to Z-contrast reveal the three-color lamellar structure with ZnO present in the PLA throughout the film thickness. This demonstrates the potential of this approach to resolve the internal structure of even thick films. Elemental mapping shows that as expected, Si is uniformly distributed in the PDMSB domain which exhibit sharp interfaces, but oxygen is also present. In fact, the oxidation appears to have occurred before the ZnO infiltration (**Figure S5**), likely due to ambient oxygen and water. The majority of Zn is selectively infiltrated into PLA but there are also ZnO particles present in the PDMSB, presumably due to its prior oxidation which could provide an increased reactivity of the PDMSB toward DEZ. Kinetic entrapment of precursors driven by weak physisorption within the polymer matrix might also contribute, as has been proposed to explain AlO_x and ZnO infiltration into PDMS.⁴⁶⁻⁴⁸ It is noted that the nominally unreactive blocks around the PLA are not expected to retard the infiltration of ZnO into the targeted PLA domain because the absence of strong interaction between infiltrating precursors and unreactive polymer domains renders their diffusion through the inert domains fast, as confirmed by a recent study by Waldman *et al.* examining the infiltration of weakly interacting organometallic precursors in homopolymer thin films.⁴⁹ This is consistent with previous reports that have shown a high-fidelity block-selective infiltration of various inorganic materials into isolated PMMA domains surrounded by a majority of unreactive PS domains.³⁰⁻³¹

Figure 3. EDS elemental mappings of both Si (red) and Zn (blue) for DSL structures: (a) DSL-L1 and (b) DSL-L2. Estimated width of each microdomain is indicated.

Based on the elemental maps for the ZnO-infiltrated DSL-L films, we estimated the periodicities and volume fraction of microdomains in each structure as shown in **Figure 3**. The period of DSL-L1 ($L_{0,L1} = 21$ nm) is larger than that of DSL-L2 ($L_{0,L2} = 16$ nm), $L_{0,L1}/L_{0,L2} = 1.31$, though the difference exceeds that predicted from the ratio of (molecular weight $(M_n)^{2/3}$, $(M_{n,L1}/M_{n,L2})^{2/3} = 1.07$. For both structures, the PDMSB domains are 1.5 times wider than the organic domains although the volume fraction of PDMSB is 36-41 %. This is attributed to preferential swelling of the PDMSB during solvent annealing which is at least partly preserved after drying.

Figure 4. (a) Schematic illustrations depicting SVA followed by **infiltration synthesis** to produce $\text{SiO}_x/\text{PS}/\text{ZnO}$ nanostructures in DSL-H films. The purple structure in the spin-coated DSL film represents as-cast DSL-H before phase separation. Schematics in **light grey**, blue, red, grey, and yellow represent PDMSB, PS, PLA, SiO_x , and ZnO, respectively. (b) Schematic illustrations (left) and HAADF STEM images (right) of the cross-sections of DSL-H1 structure before (top) and after (bottom) **infiltration** of ZnO. The junctions between the lateral and vertical PLA domains are highlighted by orange circles in the schematic and in the magnified STEM image of ZnO infiltrated DSL-H1 structure.

ZnO was infiltrated into DSL-H films *via* the same process as described in **Figure 4a**. Unlike DSL-L, the DSL-H forms Lam// through which $\text{Hex}_{\perp}$ of PLA-PS pass perpendicular to the substrate, *i.e.* the SEM indicates a morphology consisting of both in-plane and out-of-plane periodic features, a result supported by GISAXS²³ and also described for thick films of DSV.²⁵ **Figure 4b** shows cross-sectional HAADF STEM data comparing the DSL-H1 morphology before and after ZnO infiltration. This clearly shows selective ZnO infiltration into the PLA block at the junction between the lamellae and cylinders, while the un-infiltrated sample exhibits no such contrast. As illustrated in the schematics in **Figure 4b**, the wider region of ZnO visible at the cylinder–lamella intersection is attributed to widening of the PLA block at the junction between the cores of the cylinders and the thin PLA lamellae. Little ZnO is seen outside the junction areas, due to the narrowness of the PLA cores and lamellae. However, it is clear that the ZnO-decorated regions are located at the center of the vertical core-shell cylindrical domains, and the SEM depth profile and cross-section of the etched films (**Figures 1b and S2**) confirms the continuity of the vertical PLA cores.

The phase behavior of ZnO-infiltrated DSL-H2, which includes much lower fraction of PLA than DSL-H1, is shown in **Figure S6**. Thin ZnO-decorated layers are present within the PS lamellae corresponding to the PLA lamellae embedded in the PS, as seen in DSL-L1, L2 and H1. This is in agreement with the morphology of DSL-H2 resolved by employing hydrolysis to selectively degrade the PLA domains.²³ However, unlike DSL-H1, thicker ZnO-infused regions corresponding to the cores of the core-shell cylinders are not evident in the image, even though the SEM plain view and cross-section (**Figure 1b**) as well as the bright-field cross-section of the un-infiltrated DSL-H2 (**Figure S5b**) demonstrate continuous vertical cylinders. We assume that the low volume fraction of the PLA limited infiltration of Zn into the cylinder cores which were

not resolved in **Figure S6**. We note that self-assembled BCP films in general can be swelled when exposed to infiltrating precursors as organic vapors can do,⁵⁰ but our TEM data clearly indicates no disruption of the self-assembled BCP morphology by the precursor infiltration. This is most likely due to the purging step included in the infiltration protocol, which removes unreacted precursor out of the BCP film.

Unlike the HPL phase in DSV thick films where the perforations are stacked in an AB sequence,²⁵ the DSL-H in this work shows an AA stacking sequence according to the SEM and STEM images in **Figure 1 and 4**, respectively. The AA sequence refers to the perforations aligned above each other in adjacent lamellae, *i.e.* cylinders penetrating orthogonal to the lamellae. This is the same structure as we proposed in Ref (23) and it is also the structure observed in thick films of DSM blended with PDMSB-*b*-PS, which results in $f_{\text{PDMSB}}/f_{\text{PS}}/f_{\text{PMMA}} = 0.31/0.45/0.24$.⁴³ Thus, the two DSL-H here and the DSM blend in Ref (43) have similar volume fractions and are found to exhibit AA stacked Lam_{//}-Hex_⊥ under solvent annealing in CHCl₃, a morphology which has not been reported in other BCPs.

We note that the demonstrated use of block-selective infiltration in TBTPs achieves TEM contrast enhancement in a similar manner to traditional polymer staining methods based on OsO₄ and RuO₄ reagents, with the former known to oxidize polymers with olefinic functionalities and the latter to react primarily with aromatic and unsaturated polymers.⁵¹⁻⁵³ However, these methods are either very slow (*e.g.*, even up to several days),⁵² or difficult to perform due to the high toxicity of these metal oxides, and it may be hard to predict the domains to be stained due to various other chemical and structural characteristics known to affect the preferential reactivity of blocks.⁵³ On the other hand, infiltration synthesis, relying on a relatively straightforward Lewis acid-base

interaction between infiltrating precursors and polymers, allows us to predict the domain to be preferentially infiltrated and is quick and safe to implement using a commercial ALD system.

CONCLUSION

In summary, a vapor-phase infiltration synthesis was demonstrated to selectively deposit inorganic material (ZnO) into an organic block (PLA) of a triblock terpolymer film. The infiltration extends over film thicknesses of at least 260 nm and enables resolution of microdomain morphologies and volume fractions of the blocks. The triblock terpolymer, DSL, shows a transition from a three-color lamellar structure to perforated lamellae plus perpendicular core-shell cylinders on decreasing the volume fraction of the PDMSB. Environmental oxidation of the PDMSB domains formed SiO_x , and infiltration of the PLA domains with ZnO results in hierarchical ZnO/polymer/ SiO_x nanostructures. Infiltration synthesis therefore provides access to multi-component nanocomposites with both lateral and vertical periodicities as well as a process for investigating complex 3D BCP morphologies.

EXPERIMENTAL SECTION

Materials and Preparation of DSL Films. Four linear PDMSB-*b*-PS-*b*-PLA (DSL) triblock terpolymers with different volume fractions of each block in **Table 1** were synthesized *via* the combination of anionic polymerization by sequential addition of monomers and ring opening polymerization using a strong organic base as catalyst (also called pseudo anionic polymerization). A hydroxyl-terminated poly(1,1-dimethylsilacyclobutane-*b*-styrene) (PDMSB-*b*-PS-OH) was first prepared by the sequential anionic polymerization of DMSB and styrene monomers in various compositions using tetrahydrofuran/heptane (1:1) as a solvent at -48 °C accompanied by the addition of ethylene oxide. This reaction was terminated using degassed methanol in order to achieve the desired end-functionalized symmetric and asymmetric PDMSB-*b*-PS BCPs. The ring opening polymerization of D, L-lactide was then performed in toluene at 80 °C using PDMSB-*b*-PS-OH as macroinitiator in the presence of catalyst triazabicyclodecene (TBD).⁵⁴

180–260 nm thick DSL films were obtained by spin-coating 4 wt% DSL solutions in a mixture of tetrahydrofuran and propylene glycol monomethyl ether acetate (THF/PGMEA = 2:1) onto silicon substrates with native oxide layer. The as-cast film thickness was determined by the spin speed of 3,000 rpm and measured using a spectral reflectometer (FilMetrics F20-UV). All the solvents used in this study were purchased from Sigma Aldrich.

Solvent Vapor Annealing of DSL Films. Solvent vapor annealing was carried out using a continuous flow system where separate streams of nitrogen are bubbled through liquid solvents and the flow of each stream is regulated using a mass flow controller (MKS Inc., M100B).⁵⁵ As-cast DSL films on substrates were placed inside the glass annealing chamber (volume ~ 80 cm³) tightly sealed by a quartz plate along with a perfluoroelastomer O-ring (Markez Inc., Z1210), and

were annealed in a vapor flow of CHCl_3 and N_2 for ~ 1 h at ambient temperature. Solvent vapors of $\text{CHCl}_3:\text{N}_2 = 10$ sccm:1 sccm were introduced to achieve an optimal swelling ratio of ~ 2.1 and ~ 1.9 for DSL-L and DSL-H, respectively which produced well-ordered DSL morphologies. The inflow tube was connected to a mixer fed by two flow channels: pure N_2 gas (Airgas, Inc., 99.9997 % purity) for diluting the vapor pressure of CHCl_3 and a solvent bubbler which contained CHCl_3 . During the deswelling, swollen films were slowly dried over 10 min by stopping the vapor flow of CHCl_3 and N_2 followed by gently detaching the quartz lid from the chamber at room temperature.

ZnO Infiltration Synthesis in DSL Films. The infiltration synthesis of ZnO was carried out in a commercial ALD system (Cambridge Nanotech, Savannah S100) at 85°C using DEZ and TMA as metal organic precursors along with water as an oxidant. The infiltration synthesis process consists of 1 AlO_x -priming cycle followed by 6 ZnO infiltration cycles. The priming step consists of: exposure to TMA for 100 s under a static vacuum (~ 350 Torr); chamber purging using N_2 (100 sccm) for 100 s; exposure to water vapor (~ 10 Torr) for 100 s; and chamber purging using N_2 (100 sccm) for 100 s. The following ZnO infiltration cycle consists of exposure to DEZ for 6 min under a static vacuum (~ 1.7 Torr); chamber purging using N_2 (100 sccm) for 2 min; exposure to water vapor (~ 10 Torr) for 6 min; and chamber purging using N_2 (100 sccm) for 2 min.

Characterization of DSL Films. As-annealed DSL films in **Figure 1** were first etched by RIE (Plasma-Therm 790) to enhance the imaging contrast followed by Zeiss Merlin high-resolution SEM characterization at 3 kV from multiple angles. For the SEM images in plain view, the PDMSB surface layer and microdomains of organic blocks (PS and PLA) were selectively removed by RIE treatment with CF_4 (5 s, 15 mTorr, 50 W) and O_2 (30 s, 6 mTorr, 90 W), respectively. Terraced regions of PDMSB were obtained by covering the half of the sample,

etching the other half with CF₄ (60 s, 15 mTorr, 50 W) and O₂ (30 s, 6 mTorr, 90 W), and imaging the boundary between these two regions. This process yields oxidized PDMSB patterns that exhibit the morphology of the PDMSB microdomains. The cross-sections were prepared by cracking the sample in liquid nitrogen followed by RIE with O₂ (5 s, 6 mTorr, 90 W) and imaged after tilting the sample 70° to the SEM detector. The as-infiltrated organic-inorganic hybrids were characterized by TEM (JEOL 2100; 200 kV), and scanning TEM (FEI Talos F200X; 200 kV; equipped with the EDS elemental mapping capability). The cross-sectional TEM samples were prepared by the standard *in situ* lift-out procedure using Ga ion milling in a focused ion beam system (FEI Helios 600 Nanolab).

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ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website.

Additional information on SAXS patterns for the bulk morphologies, top view SEM images showing the vertical core-shell cylinders, and cross-sectional TEM/STEM images with EDS areal elemental mappings for DSL-L and DSL-H films

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Notes

The authors declare no competing financial interest

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